

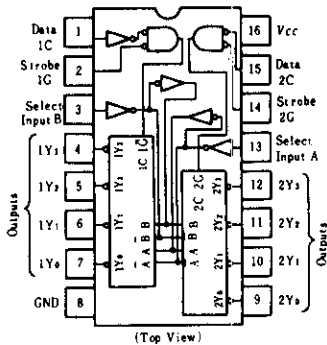
HD74LS156

●Dual 2-line-to-4-line Decoders/Demultiplexers (with open collector outputs)

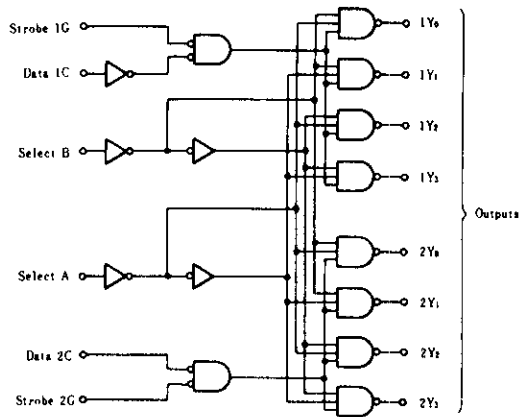
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This circuit features dual 1-line-to-4-line demultiplexer with individual strobes and common binary-address inputs. When both sections are enabled by the strobes, the common binary-address inputs sequentially select and route associated input data to the appropriate output of each section. The individual strobes permit activating or inhibiting each of the 4-bit sections as desired. Data applied to input 1C is inverted through its outputs. The inverter following the 1C data input permits use as a 3-to-8-line decoder or 1-to-8-line demultiplexer without external gating.

PIN ARRANGEMENT



BLOCK DIAGRAM



RECOMMENDED OPERATING CONDITIONS

Item	Symbol	min	typ	max	Unit
High level output voltage	V_{OH}	—	—	5.5	V
Low level output current	I_{OL}	—	—	8	mA

FUNCTION TABLE

2-to-4-line Decoder/1-to-4-line Demultiplexer

Inputs				Outputs				Inputs				Outputs			
SELECT		STROBE	DATA					SELECT		STROBE	DATA				
B	A	1G	1C	1Y0	1Y1	1Y2	1Y3	B	A	2G	2C	2Y0	2Y1	2Y2	2Y3
X	X	H	X	H	H	H	H	X	X	H	X	H	H	H	H
L	L	L	H	L	H	H	H	L	L	L	L	L	H	H	H
L	H	L	H	H	L	H	H	L	H	L	L	H	L	H	H
H	L	L	H	H	H	L	H	H	L	L	L	H	H	L	H
H	H	L	H	H	H	H	L	H	H	L	L	H	H	H	L
X	X	X	L	H	H	H	H	X	X	X	H	H	H	H	H

3-to-8-line Decoder/1-to-8-line Demultiplexer

Inputs			Outputs								
SELECT			STROBE OR DATA	(0)	(1)	(2)	(3)	(4)	(5)	(6)	(7)
C ¹⁾	B	A	G ²⁾	2Y0	2Y1	2Y2	2Y3	1Y0	1Y1	1Y2	1Y3
X	X	X	H	H	H	H	H	H	H	H	H
L	L	L	L	L	H	H	H	H	H	H	H
L	L	H	L	H	L	H	H	H	H	H	H
L	H	L	L	H	H	L	H	H	H	H	H
L	H	H	L	H	H	H	L	H	H	H	H
H	L	L	L	H	H	H	H	L	H	H	H
H	L	H	L	H	H	H	H	H	L	H	H
H	H	L	L	H	H	H	H	H	H	L	H
H	H	H	L	H	H	H	H	H	H	H	L

- Notes) 1. C: input 1C and 2C connected together
2. G: inputs 1G and 2G connected together
3. H: high level, L: low level, X: irrelevant

HD74LS156

■ ELECTRICAL CHARACTERISTICS ($T_a = -20 \sim +75^{\circ}\text{C}$)

Item	Symbol	Test Conditions	min	typ*	max	Unit
Input voltage	V_{IH}		2.0	—	—	V
	V_{IL}		—	—	0.8	V
Output current	I_{OH}	$V_{CC}=4.75V, V_{IH}=2V, V_{IL}=0.8V, V_{OH}=5.5V$	—	—	100	μA
Output voltage	V_{OL}	$V_{CC}=4.75V, V_{IH}=2V, V_{IL}=0.8V$ $I_{OL}=4mA$	—	—	0.4	V
		$I_{OL}=8mA$	—	—	0.5	
Input current	I_{IH}	$V_{CC}=5.25V, V_I=2.7V$	—	—	20	μA
	I_{IL}	$V_{CC}=5.25V, V_I=0.4V$	—	—	—0.4	mA
	I_I	$V_{CC}=5.25V, V_I=7V$	—	—	0.1	mA
Supply current**	I_{CC}	$V_{CC}=5.25V$	—	6.1	10	mA
Input clamp voltage	V_{IK}	$V_{CC}=4.75V, I_{IN}=-18mA$	—	—	—1.5	V

* $V_{CC}=5V, T_a=25^{\circ}C$

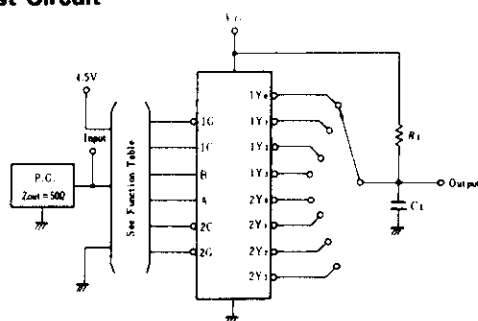
** I_{CC} is measured with outputs open, A, B, and 1C inputs at 4.5V, and 2C, 1G, and 2G inputs grounded.

■ SWITCHING CHARACTERISTICS ($V_{CC}=5V$, $T_a=25^{\circ}C$)

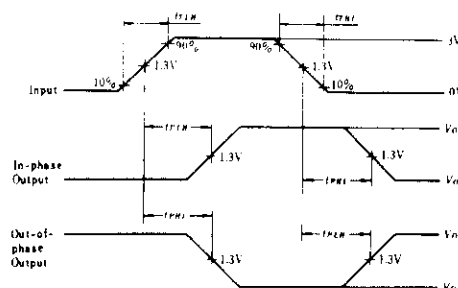
Item	Symbol	Inputs	Output	Level of logic	Test Conditions	min	typ	max	Unit
Propagation delay time	t_{PLH}	A, B, 2C, 1G or 2G	Y	2	$C_L = 15\text{pF}$, $R_t = 2\text{k}\Omega$	—	25	40	ns
	t_{PHL}	A, B, 2C, 1G or 2G	Y	2		—	34	51	
	t_{PLH}	A or B	Y	3		—	31	46	
	t_{PHL}	A or B	Y	3		—	34	51	
	t_{PLH}	1C	Y	3		—	32	48	
	t_{PHL}	1C	Y	3		—	32	48	

■ TESTING METHOD

1) Test Circuit

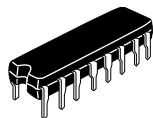
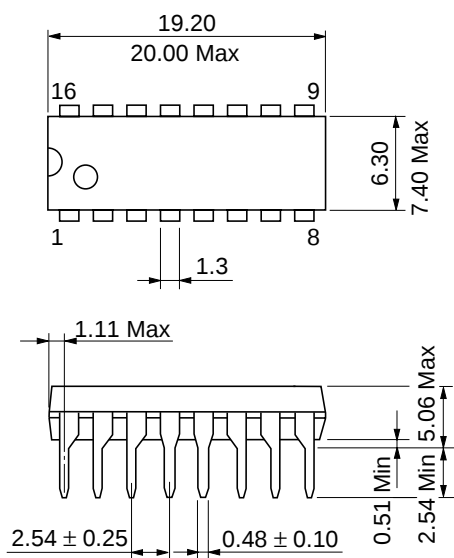


Waveform

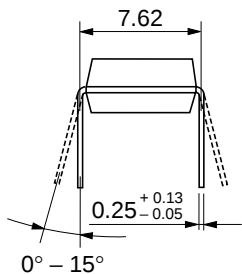


Notes) 1. Input pulse; $t_{LH} \leq 15\text{ns}$, $t_{THL} \leq 6\text{ns}$, $PRR=1\text{MHz}$,
duty cycle=50%.

2. C_L includes probe and jig capacitance.

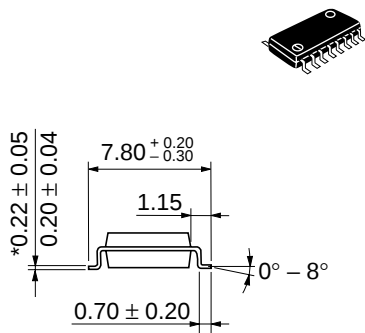
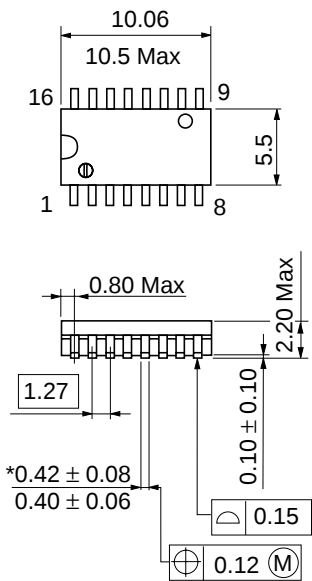


Unit: mm



Hitachi Code	DP-16
JEDEC	Conforms
EIAJ	Conforms
Weight (reference value)	1.07 g

Unit: mm

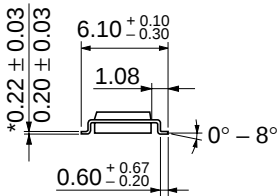
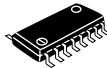
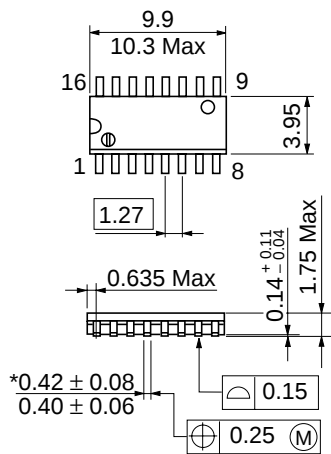


*Dimension including the plating thickness
Base material dimension

Hitachi Code	FP-16DA
JEDEC	—
EIAJ	Conforms
Weight (reference value)	0.24 g

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Unit: mm



*Dimension including the plating thickness
 Base material dimension

Hitachi Code	FP-16DN
JEDEC	Conforms
EIAJ	Conforms
Weight (reference value)	0.15 g

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